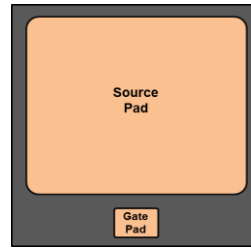


Description

United Silicon Carbide, Inc offers the high-performance G3 SiC normally-on JFET transistors. This series exhibits ultra-low on resistance ($R_{DS(ON)}$) and gate charge (Q_G) allowing for low conduction and switching loss. The device normally-on characteristics with low $R_{DS(ON)}$ at $V_{GS} = 0\text{ V}$ is also ideal for current protection circuits without the need for active control, as well as for cascode operation.



Part Number	Package
UJ3N065080	Undiced wafer
UJ3N065080Z	Die on tape

Features

- ◆ Typical on-resistance $R_{DS(on),typ}$ of 80mΩ
- ◆ Voltage controlled
- ◆ Maximum operating temperature of 175°C
- ◆ Extremely fast switching not dependent on temperature
- ◆ Low gate charge
- ◆ Low intrinsic capacitance
- ◆ RoHS compliant

Typical Applications

- ◆ Over current protection circuits
- ◆ DC-AC inverters
- ◆ Switch mode power supplies
- ◆ Power factor correction modules
- ◆ Motor drives
- ◆ Induction heating

Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V_{DS}		650	V
Gate-source voltage	V_{GS}	DC	-20 to +3	V
		AC ⁽¹⁾	-20 to +20	
Continuous drain current ^(2,3)	I_D	$T_C = 25^\circ\text{C}$	32	A
		$T_C = 100^\circ\text{C}$	24	A
Pulsed drain current ^(3,4)	I_{DM}	$T_C = 25^\circ\text{C}$	72	A
Maximum junction temperature ⁽⁵⁾	$T_{J,max}$		175	°C
Operating and storage temperature	T_J, T_{STG}		-55 to 175	°C

(1) +20V AC rating applies for turn-on pulses <200ns applied with external $R_G > 1\Omega$.

(2) Limited by $T_{J,max}$

(3) Assumes a maximum junction-to-case thermal resistance of 0.79°C/W

(4) Pulse width t_p limited by $T_{J,max}$

(5) Package limited

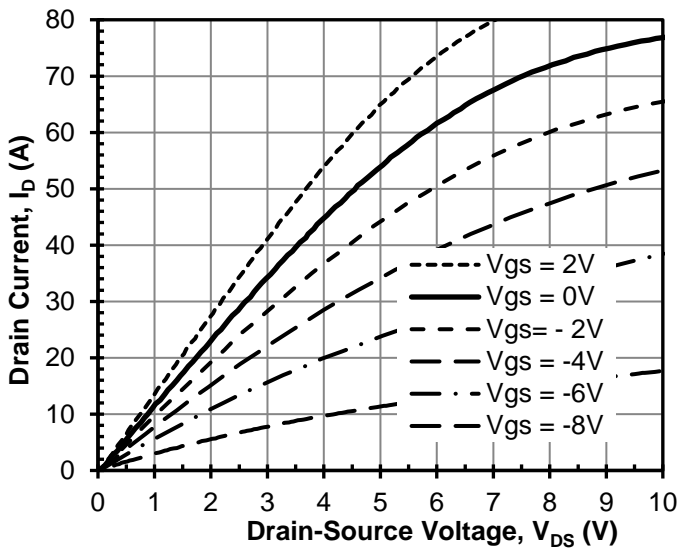
Electrical Characteristics ($T_J = +25^\circ\text{C}$ unless otherwise specified)

Typical Performance - Static

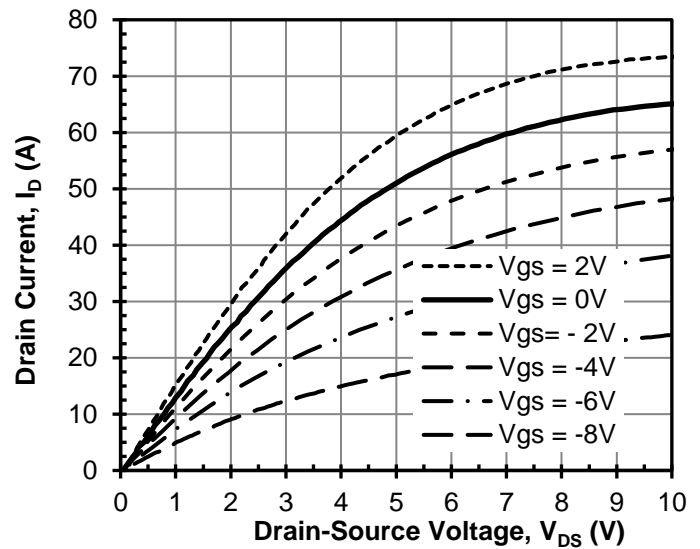
Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Drain-source breakdown voltage	BV_{DS}	$V_{GS} = -20\text{V}, I_D = 1\text{mA}$	650			V
Total drain leakage current	I_D	$V_{DS} = 650\text{V},$ $V_{GS} = -20\text{V}, T_J = 25^\circ\text{C}$		8	60	μA
		$V_{DS} = 650\text{V},$ $V_{GS} = -20\text{V}, T_J = 175^\circ\text{C}$		30		
Total gate leakage current	I_G	$V_{GS} = -20\text{V}, T_J = 25^\circ\text{C}$		10	50	μA
		$V_{GS} = -20\text{V}, T_J = 175^\circ\text{C}$		32		
Drain-source on-resistance	$R_{DS(on)}$	$V_{GS} = 2\text{V}, I_D = 10\text{A},$ $T_J = 25^\circ\text{C}$		68		mΩ
		$V_{GS} = 0\text{V}, I_D = 10\text{A},$ $T_J = 25^\circ\text{C}$		80	95	
		$V_{GS} = 2\text{V}, I_D = 10\text{A},$ $T_J = 175^\circ\text{C}$		114		
		$V_{GS} = 0\text{V}, I_D = 10\text{A},$ $T_J = 175^\circ\text{C}$		130		
Gate threshold voltage	$V_{G(th)}$	$V_{DS} = 5\text{V}, I_D = 20\text{mA}$	-14	-11.5	-6	V
Gate resistance	R_G	f = 1MHz, open drain		3.7		Ω

Typical Performance - Dynamic (Refer to the datasheet of the packaged device UJ3N065070K3S)

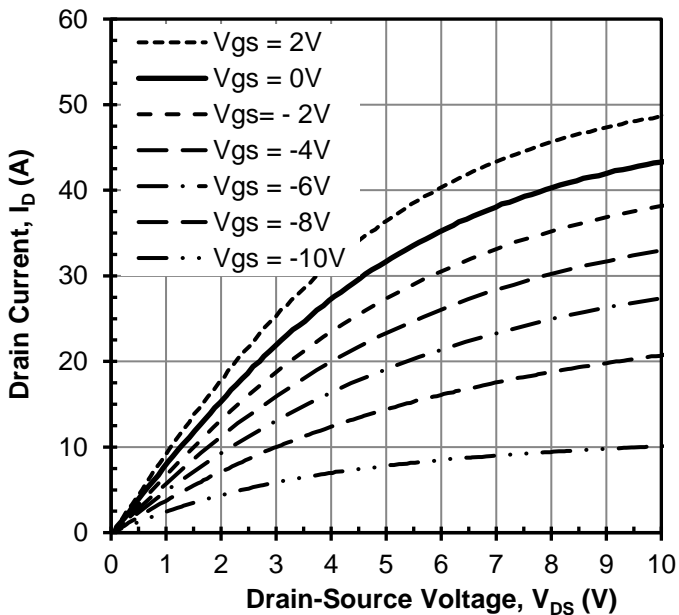
Parameter	symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Input capacitance	C_{iss}	$V_{DS} = 100V,$ $V_{GS} = -20V,$ $f = 100kHz$		630		pF
Output capacitance	C_{oss}			94		
Reverse transfer capacitance	C_{rss}			88		
Effective output capacitance, energy related	$C_{oss(er)}$	$V_{DS} = 0V$ to 400V, $V_{GS} = -20V$		69		pF
Total gate charge	Q_G	$V_{DS}=400V, I_D = 24A,$ $V_{GS}=-18V$ to 0V		75		nC
Gate-drain charge	Q_{GD}			43		
Gate-source charge	Q_{GS}			7		
Turn-on delay time	$t_{d(on)}$	$V_{DS}=400V, I_D=24A,$ Gate Driver =-18V to 0V, $R_{G,EXT} = 1\Omega,$ Inductive Load, FWD: UJ3D06510TS $T_J = 25^\circ C$		6		ns
Rise time	t_r			25		
Turn-off delay time	$t_{d(off)}$			14		
Fall time	t_f			31		
Turn-on energy	E_{ON}			149		
Turn-off energy	E_{OFF}		183		μJ	
Total switching energy	E_{TOTAL}		332			
Turn-on delay time	$t_{d(on)}$	$V_{DS}=400V, I_D=24A,$ Gate Driver =-18V to 0V, $R_{G,EXT} = 1\Omega,$ Inductive Load, FWD: UJ3D06510TS $T_J = 150^\circ C$		6		ns
Rise time	t_r			24		
Turn-off delay time	$t_{d(off)}$			14		
Fall time	t_f			14		
Turn-on energy	E_{ON}			134		
Turn-off energy	E_{OFF}			103		
Total switching energy	E_{TOTAL}		237			

Typical Performance Diagrams


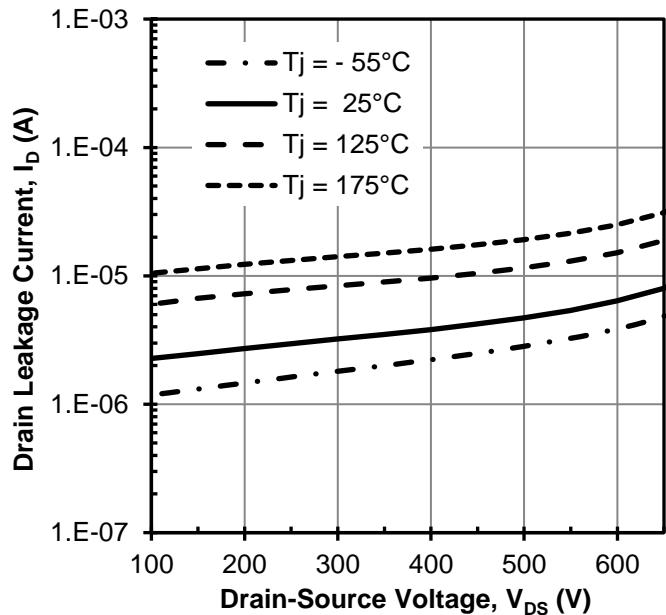
**Figure 1 Typical output characteristics
at $T_J = 55^\circ\text{C}$**



**Figure 2 Typical output characteristics
at $T_J = 25^\circ\text{C}$**



**Figure 3 Typical output characteristics
at $T_J = 175^\circ\text{C}$**



**Figure 4 Typical drain-source leakage
at $V_{GS} = -20\text{V}$**

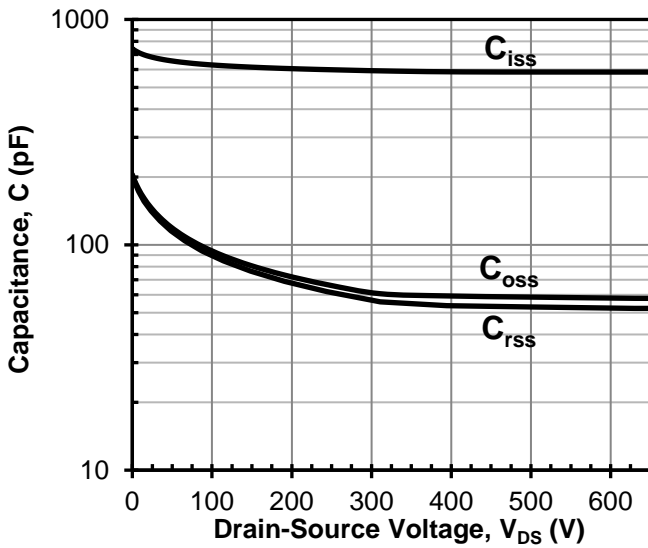


Figure 5 Typical capacitances at 100kHz and $V_{GS} = -20V$

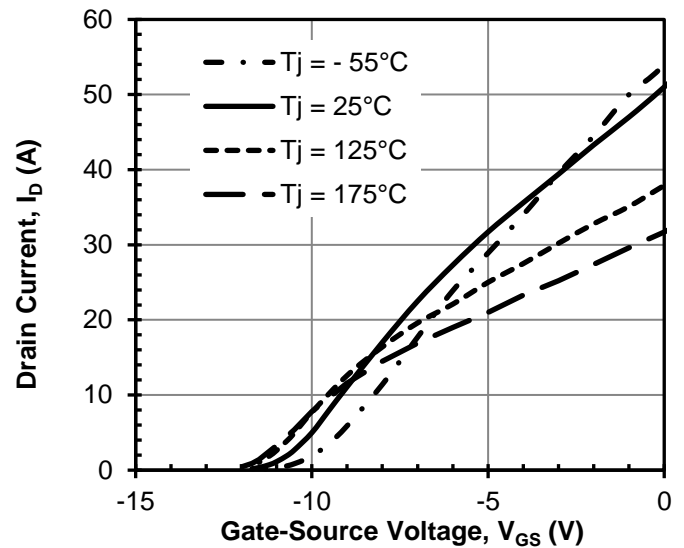


Figure 6 Typical transfer characteristics at $V_{DS} = 5V$

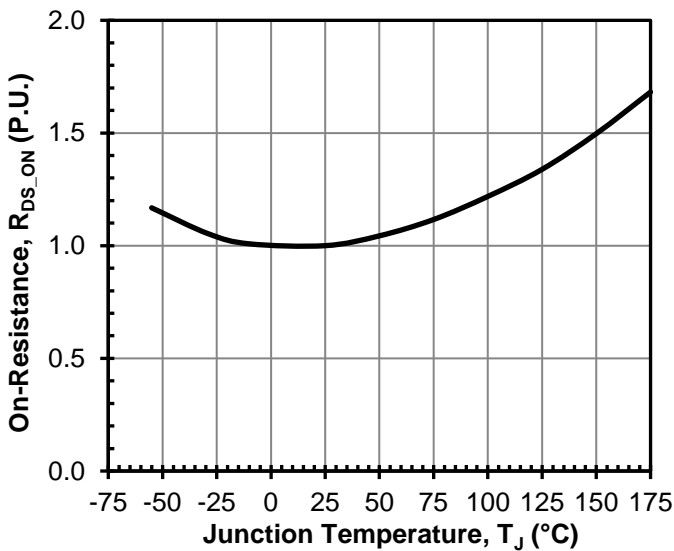


Figure 7 Normalized on-resistance vs. temperature at $V_{GS} = 0V$ and $I_D = 10A$

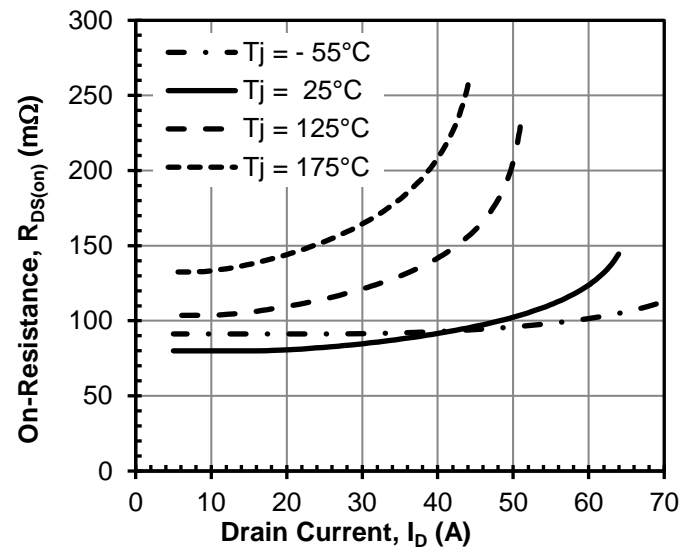


Figure 8 Typical drain-source on-resistance at $V_{GS} = 0V$

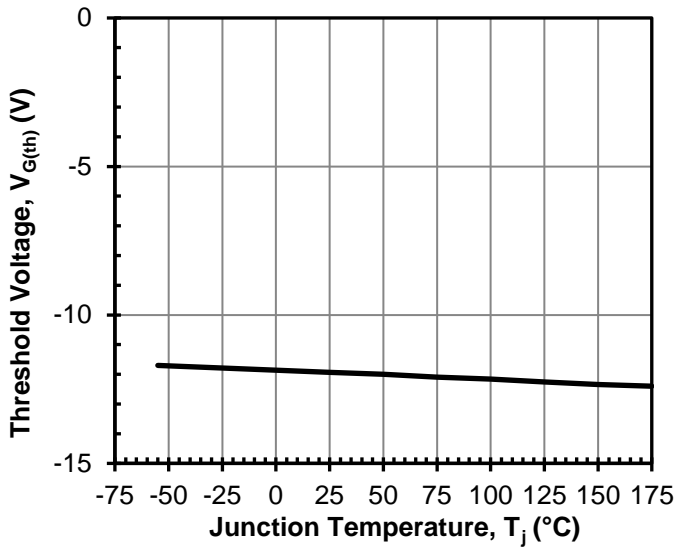


Figure 9 Threshold voltage vs. T_j
at $V_{DS} = 5V$ and $I_D = 20mA$

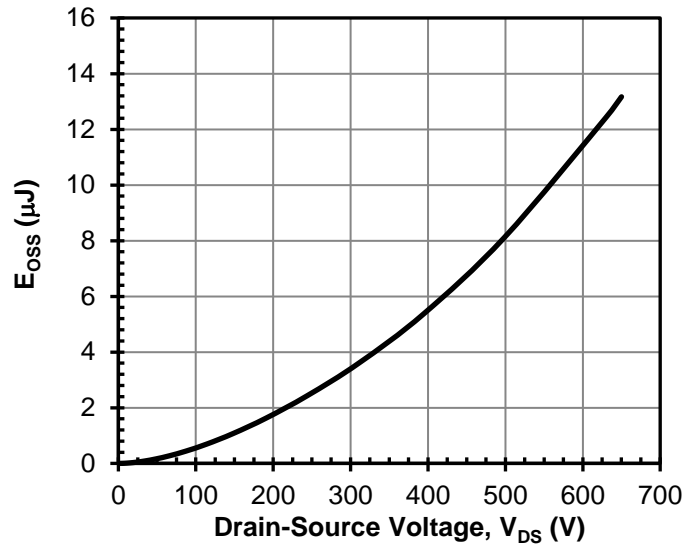


Figure 10 Typical stored energy in C_{OSS}
at $V_{GS} = -20V$

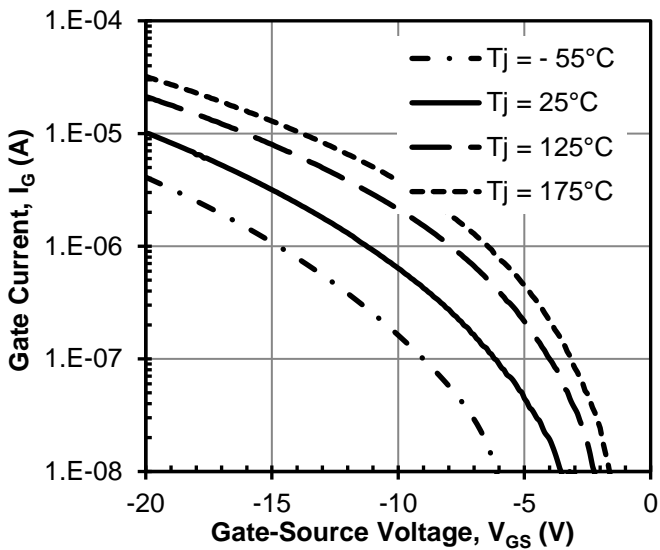


Figure 11 Typical gate leakage current
at $V_{DS} = 0V$

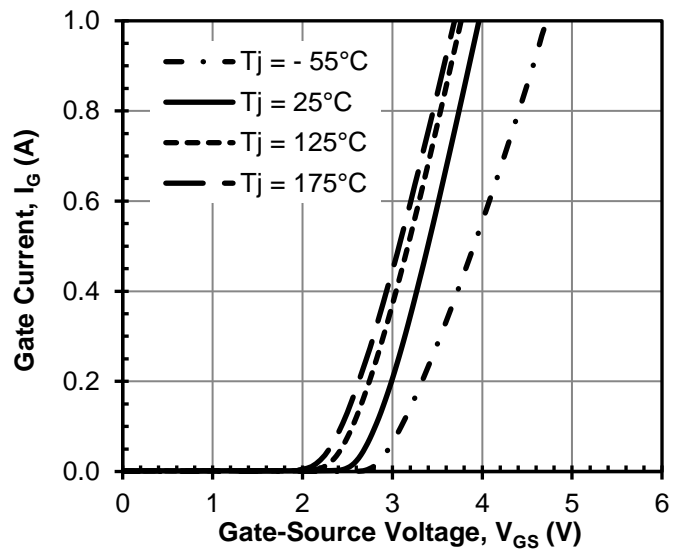


Figure 12 Typical gate forward current
at $V_{DS} = 0V$

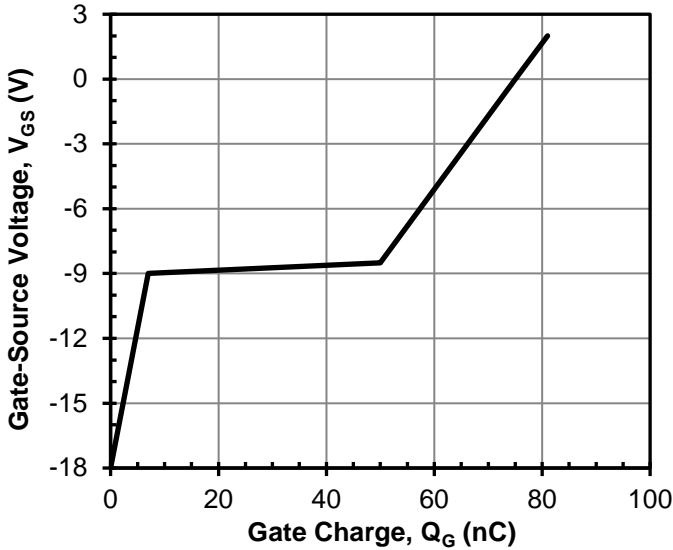


Figure 13 Typical gate charge
at $V_{DS} = 400V$ and $I_D = 24A$

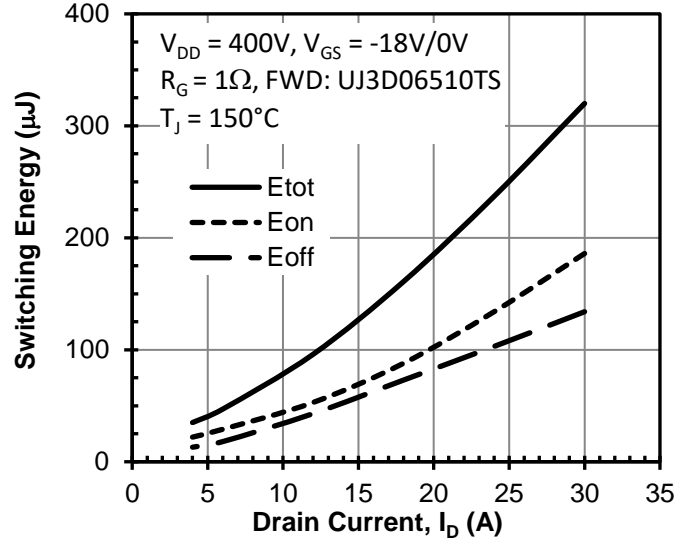


Figure 14 Clamped inductive switching energy vs. drain current at $T_J = 150^\circ C$

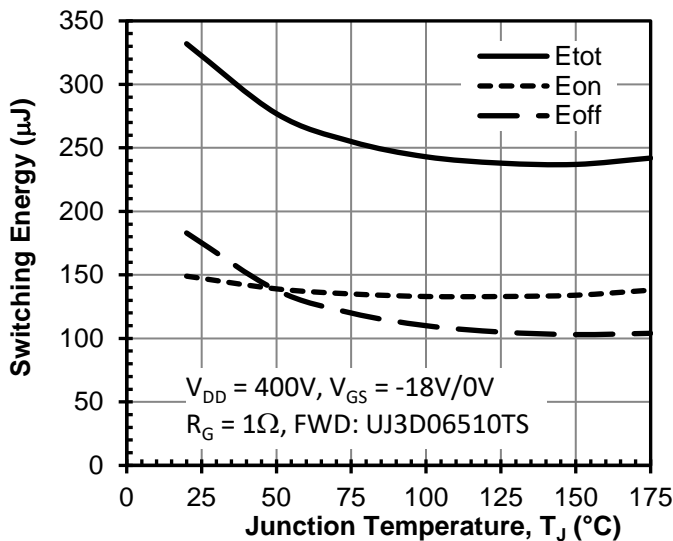


Figure 15 Clamped inductive switching energy vs. junction temperature at $I_D = 24A$

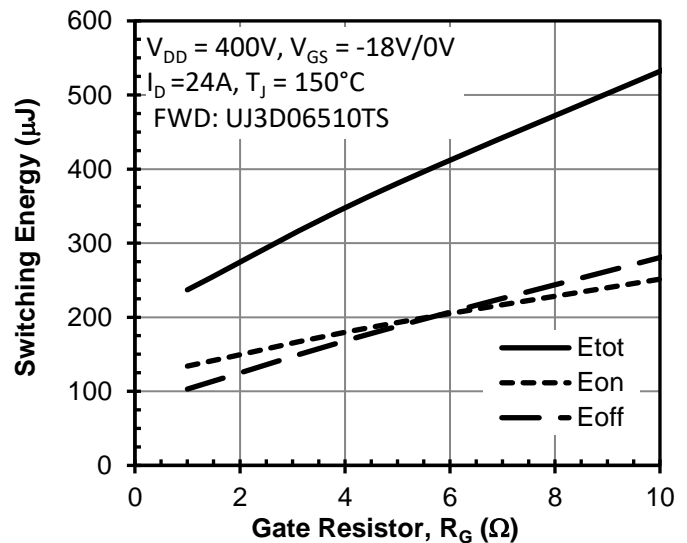
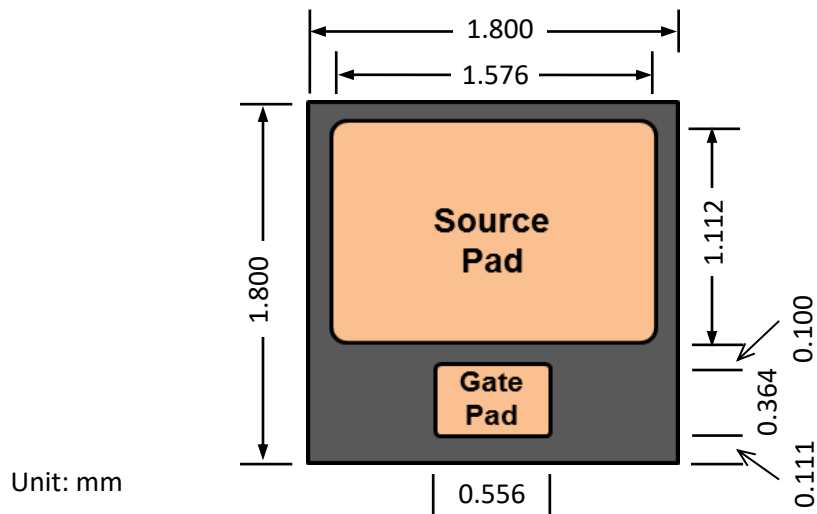


Figure 16 Clamped inductive switching energy vs. gate resistor R_G

Mechanical Characteristics

Parameter	Typical Value	Units
Die Dimensions with Scribe Line (L x W)	1.800 x 1.800	mm
Scribe Line width	80	μm
Source Pad Metal Dimensions (L x W)	1.576 x 1.112	mm
Gate Pad Metal Dimensions (L x W)	0.556 x 0.364	mm
Source Metallization (AlCu)	5	μm
Gate Metallization (AlCu)	5	μm
Backside Drain Metallization (Ti/Ni/Ag)	0.1/0.2/1	μm
Frontside Passivation	Polyimide	
Die Thickness	150	μm
Wafer Size	150	mm
Gross Die Per Wafer	4,376	

Chip Dimensions

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